Notice of References Cited

Ī	Application/Control No.	Applicant(s)/Pater	nt Under
	10/576,023	Reexamination TOSHIKIYO, KIM	IAKI
	Examiner	Art Unit	
	Dwight Alex C. Tejano	2622	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. I ATENT DOGGMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0044729 A1	03-2003	Huang et al.	430/321
*	В	US-2006/0125948 A1	06-2006	Orita et al.	348/340
*	O	US-2005/0195485 A1	09-2005	Hirai et al.	359/569
*	D	US-2004/0042801 A1	03-2004	Wedding, Berthold	398/193
*	Е	US-2003/0231395 A1	12-2003	Nakai, Takehiko	359/558
*	F	US-5,978,139 A	11-1999	Hatakoshi et al.	359/565
*	G	US-2003/0164922 A1	09-2003	Robins et al.	349/201
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U			
	v			
	w			
	x			

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.